



**THE DATASHEET OF
FDZ2554PZ**



FDZ2554P

Monolithic Common Drain P-Channel 2.5V Specified Power Trench® BGA MOSFET -20V, -6.5A, 28mΩ

Features

- Max $r_{DS(on)}$ = 28mΩ at $V_{GS} = -4.5V$, $I_D = -6.5A$
- Max $r_{DS(on)}$ = 45mΩ at $V_{GS} = -2.5V$, $I_D = -5A$
- Occupies only 0.10 cm² of PCB area: 1/3 the area of SO-8
- Ultra-thin package: less than 0.80 mm height when mounted to PCB
- Outstanding thermal transfer characteristics: significantly better than SO-8
- Ultra-low $Q_g \times r_{DS(on)}$ figure-of-merit
- High power and current handling capability
- RoHS Compliant

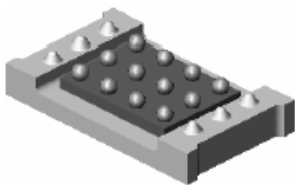


General Description

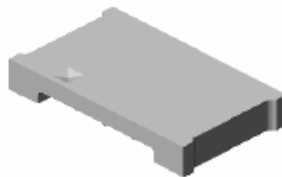
Combining Fairchild's advanced 2.5V specified PowerTrench process with state-of-the-art BGA packaging, the FDZ2554P minimizes both PCB space and $r_{DS(on)}$. This monolithic common drain BGA MOSFET embodies a breakthrough in packaging technology which enables the device to combine excellent thermal transfer characteristics, high current handling capability, ultra-low profile packaging, low gate charge, and low $r_{DS(on)}$.

Applications

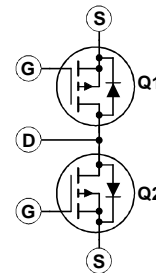
- Battery management
- Load Switch
- Battery protection



Bottom



Top



MOSFET Maximum Ratings $T_A = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Rated	Units
V_{DS}	Drain to Source Voltage	-20	V
V_{GS}	Gate to Source Voltage	± 12	V
I_D	Drain Current -Continuous (Note 1a)	-6.5	A
	-Pulsed	-20	
P_D	Power Dissipation (Steady State) (Note 1a)	2.1	W
T_J, T_{STG}	Operating and Storage Junction Temperature Range	-55 to +150	$^\circ\text{C}$

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case (Note 1)	0.6	$^\circ\text{C/W}$
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	60	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1b)	108	
$R_{\theta JB}$	Thermal Resistance, Junction to Ball (Note 1)	6.3	

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
2554P	FDZ2554P	BGA 2.5X4.0	7"	12 mm	3000 units

Electrical Characteristics $T_J = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
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Off Characteristics

BV_{DSS}	Drain to Source Breakdown Voltage	$I_D = -250\mu\text{A}, V_{GS} = 0\text{V}$	-20			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = -250\mu\text{A}$, referenced to 25°C		-13		mV/ $^\circ\text{C}$
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = -16\text{V}, V_{GS} = 0\text{V}$			-1	μA
I_{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 12\text{V}, V_{DS} = 0\text{V}$			± 100	nA

On Characteristics

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = -250\mu\text{A}$	-0.6	-0.8	-1.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = -250\mu\text{A}$, referenced to 25°C		3		mV/ $^\circ\text{C}$
$r_{DS(on)}$	Static Drain to Source On Resistance	$V_{GS} = -4.5\text{V}, I_D = -6.5\text{A}$		21	28	m Ω
		$V_{GS} = -2.5\text{V}, I_D = -5\text{A}$		36	45	
		$V_{GS} = -4.5\text{V}, I_D = -6.5\text{A}, T_J = 125^\circ\text{C}$		30	43	
g_{FS}	Forward Transconductance	$V_{DD} = -5\text{V}, I_D = -6.5\text{A}$		24		S

Dynamic Characteristics

C_{iss}	Input Capacitance	$V_{DS} = -10\text{V}, V_{GS} = 0\text{V}, f = 1\text{MHz}$		1430	1900	pF
C_{oss}	Output Capacitance			319	425	pF
C_{rss}	Reverse Transfer Capacitance			164	245	pF
R_g	Gate Resistance	$V_{GS} = 15\text{mV}, f = 1\text{MHz}$		9.2		Ω

Switching Characteristics

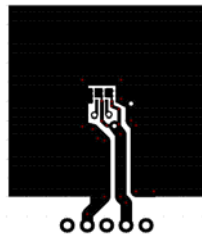
$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = -10\text{V}, I_D = -1\text{A}, V_{GS} = -4.5\text{V}, R_{GEN} = 6\Omega$		12	22	ns
t_r	Rise Time			9	18	ns
$t_{d(off)}$	Turn-Off Delay Time			62	100	ns
t_f	Fall Time			37	60	ns
Q_g	Total Gate Charge	$V_{GS} = -4.5\text{V}, V_{DD} = -10\text{V}$		14	20	nC
Q_{gs}	Gate to Source Charge	$I_D = -6.5\text{A}$		3		nC
Q_{gd}	Gate to Drain "Miller" Charge			4		nC

Drain-Source Diode Characteristics

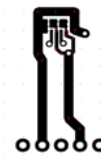
I_S	Maximum Continuous Drain-Source Diode Forward Current			-1.75	A	
V_{SD}	Source to Drain Diode Forward Voltage	$V_{GS} = 0\text{V}, I_S = -1.75\text{A}$ (Note 2)	-0.7	-1.2	V	
t_{rr}	Reverse Recovery Time	$I_F = -6.5\text{A}, di/dt = 100\text{A}/\mu\text{s}$		25	40	ns
Q_{rr}	Reverse Recovery Charge			20	32	nC

NOTES:

- $R_{\theta JA}$ is determined with the device mounted on a 1 in² oz. copper pad on a 1.5 x 1.5 in. board of FR-4 material. The thermal resistance from the junction to the circuit board side of the solder ball, $R_{\theta JB}$, is defined for reference. For $R_{\theta JC}$, the thermal reference point for the case is defined as the top surface of the copper chip carrier. $R_{\theta JC}$ and $R_{\theta JB}$ are guaranteed by design while $R_{\theta JA}$ is determined by the user's board design.



a. 60°C/W when mounted on a 1 in² pad of 2 oz copper.



b. 108°C/W when mounted on a minimum pad of 2 oz copper.

- Pulse Test: Pulse Width < 300 μs , Duty cycle < 2.0%.

Typical Characteristics $T_J = 25^\circ\text{C}$ unless otherwise noted

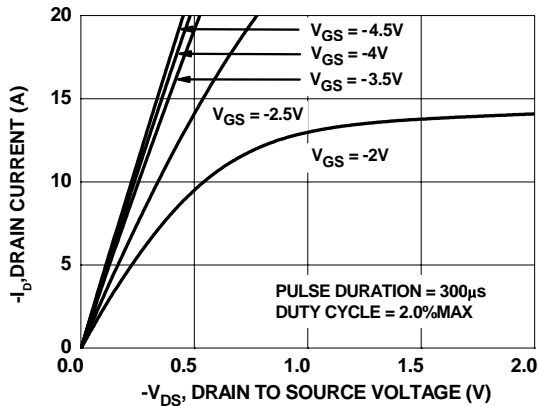


Figure 1. On-Region Characteristics

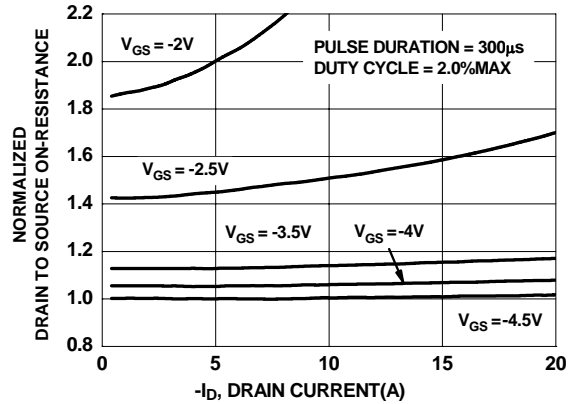


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

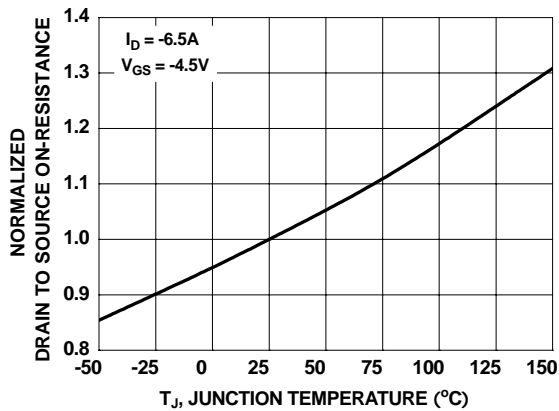


Figure 3. Normalized On-Resistance vs Junction Temperature

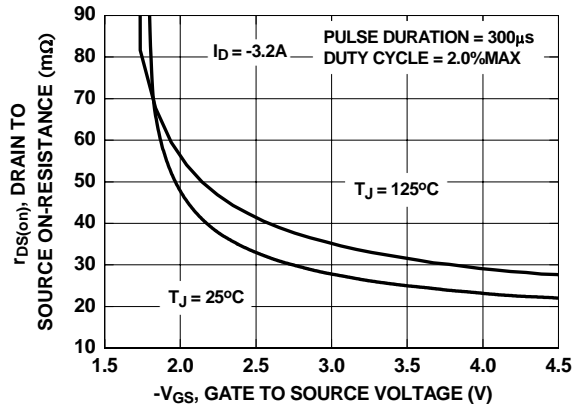


Figure 4. On-Resistance vs Gate to Source Voltage

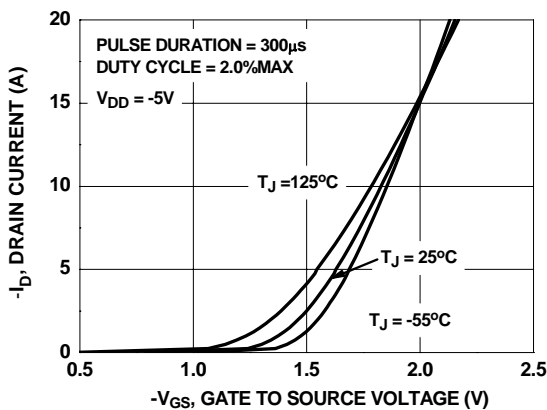


Figure 5. Transfer Characteristics

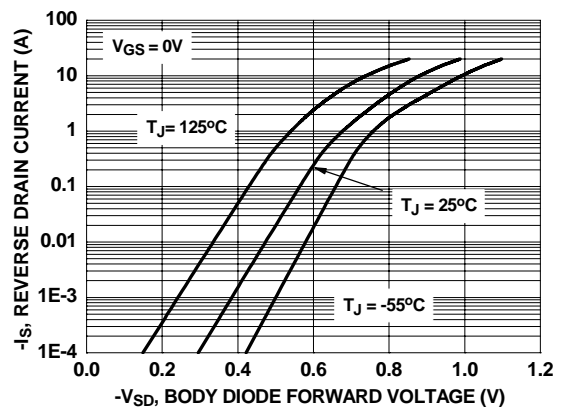


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics $T_J = 25^\circ\text{C}$ unless otherwise noted

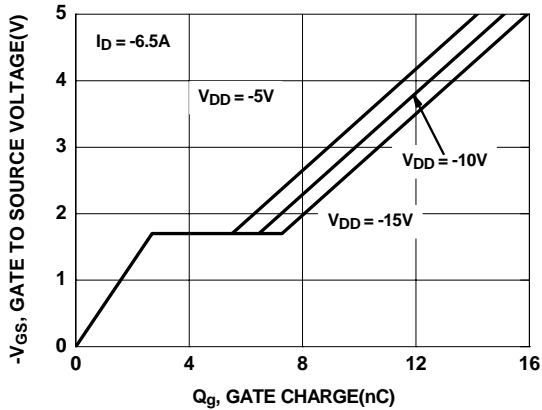


Figure 7. Gate Charge Characteristics

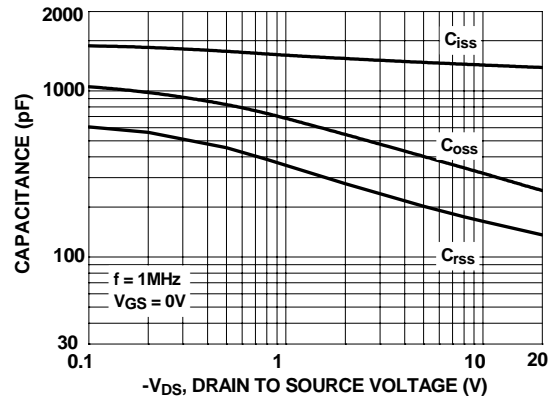


Figure 8. Capacitance vs Drain to Source Voltage

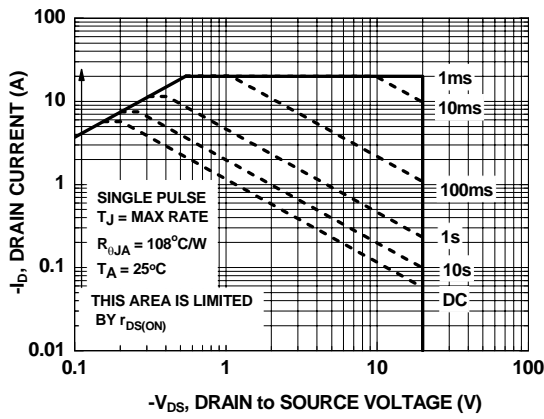


Figure 9. Forward Bias Safe Operating Area

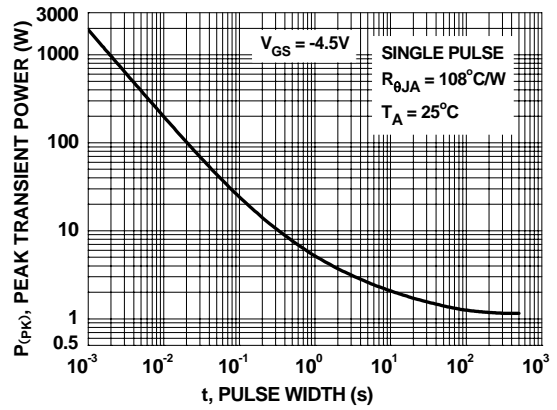


Figure 10. Single Pulse Maximum Power Dissipation

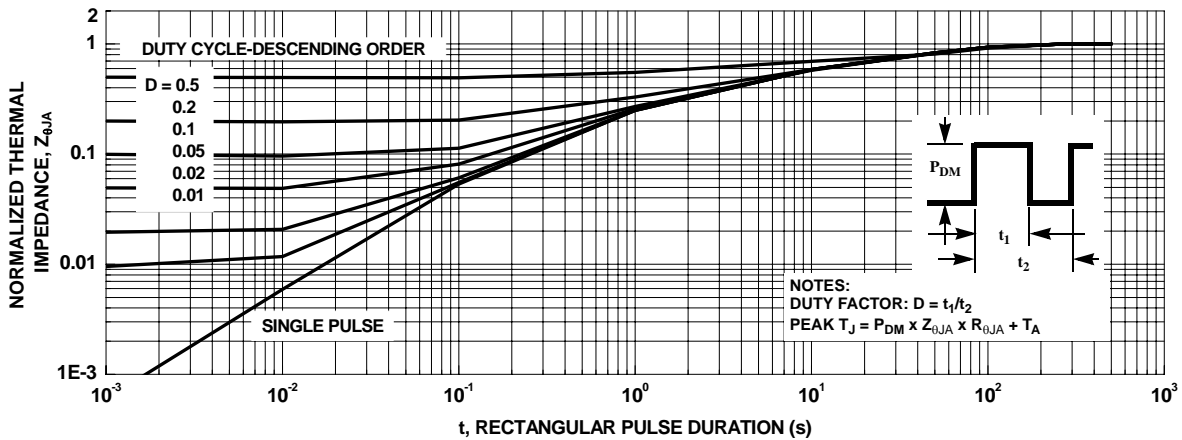
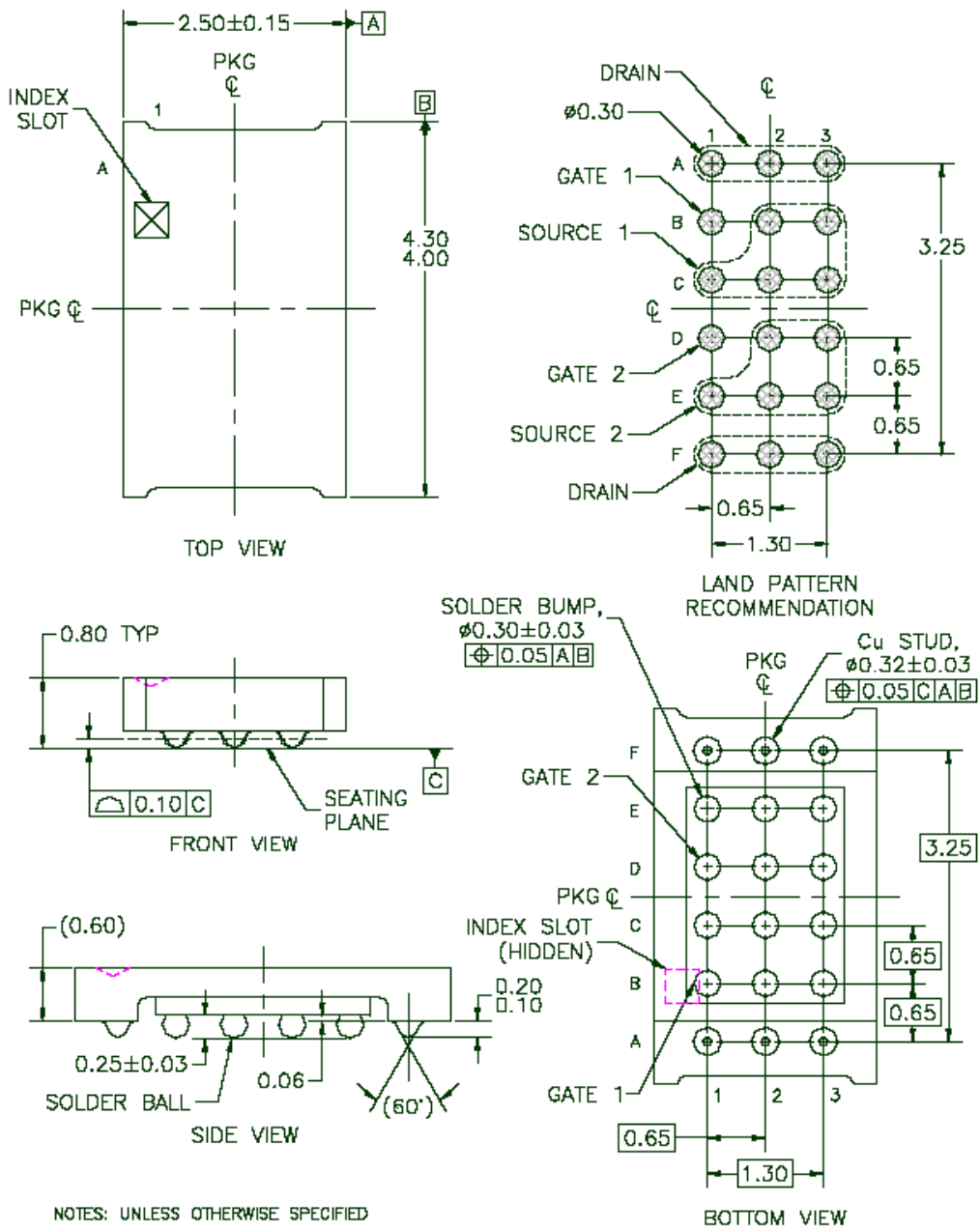


Figure 11. Transient Thermal Response Curve

Dimensional Outline and Pad Layout





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